## ARMI MBH

# Certificate of Analysis IARM NiN155-18

### Nickel Alloy, N-155 / R30155 Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

ΑΙ	<b>0.153</b> ± 0.008	В	<b>0.0024</b> ± 0.0004	С	<b>0.116 ±</b> 0.003	Со	<b>19.2</b> ±0.1
Cr	<b>20.9</b> ±0.2	Cu	<b>0.039</b> ± 0.002	Fe	<b>31.4</b> ±0.3	Mn	<b>1.46</b> ± 0.02
Мо	<b>2.87</b> ± 0.03	Ν	<b>0.12</b> ± 0.01	Nb	<b>1.00</b> ± 0.02	Ni	<b>20.1</b> ± 0.2
Ρ	<b>0.008</b> ± 0.001	Si	<b>0.55</b> ±0.01	Ti	<b>0.0026</b> ± 0.0006	V	<b>0.0236</b> ± 0.0008
W	<b>2.42</b> ± 0.03	Zr	<b>0.0057</b> ± 0.0009				

		In	dicative Values liste	d in ppm		
H (4)	Mg (8)	O (10)	Re (<100)	S (9)	Sn (<50)	Ta (10)

#### **Description and Intended Use**

This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** certified laboratories. This CRM may come in the form of a solid disk, chips, or powder. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

#### Instructions for Use

- 1. The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface.
- 2. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams.
- 3. The material should be stored in a cool, dry location when not in use.
- 4. Chips are not recommended for gas analysis.

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The following data represents al	pertinent information re	eported as it applies to the	chemical characterization of this material.
The following data reprocession a			

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	AI	B	С	Со	Cr	Cu	Fe	H	Mg	Mn	Mo	N	Nb	Ni	0	Р
1	0.1393	0.0018	0.1043	18.93	20.33	0.0336	31.00	0.0004	0.0006	1.410	2.780	0.0942	0.9630	19.60	0.0003	0.0044
2	0.1410	0.0020	0.1150	19.00	20.68	0.0340	31.01		0.0007	1.426	2.810	0.0960	0.9695	19.64	0.0007	0.0055
3	0.1420	0.0023	0.1150	19.00	20.69	0.0370	31.20		0.0008	1.446	2.844	0.1153	0.9700	19.80	0.0015	0.0066
4	0.1422	0.0024	0.1160	19.07	20.72	0.0370	31.38		0.0008	1.450	2.850	0.1200	0.9860	19.96	0.0018	0.0073
5	0.1460	0.0024	0.1160	19.08	20.73	0.0375	31.53		0.0008	1.452	2.857	0.1218	0.9950	19.97		0.0080
6	0.1470	0.0024	0.1163	19.30	20.91	0.0380	31.70		0.0009	1.461	2.860	0.1230	1.0100	19.97		0.0081
7	0.1490	0.0027	0.1200	19.32	20.96	0.0389	31.74		<0.0005	1.462	2.888	0.1260	1.0131	20.06		0.0083
8	0.1498	0.0035	0.1200	19.33	21.00	0.0397	31.85		≤0.005	1.470	2.890	0.1440	1.0170	20.26		0.0087
9	0.1500		0.1203	19.36	21.06	0.0400			≤0.005	1.473	2.890		1.0200	20.30		0.0089
10	0.1520		0.1205	19.43	21.08	0.0400				1.480	2.892		1.0220	20.43		0.0093
11	0.1680			19.43	21.10	0.0413				1.482	2.893		1.0366	20.54		0.0100
12	0.1770				21.36	0.0427				1.482	2.926			20.60		
13	0.1792				21.54	0.0432				1.520	2.950			_0.00		
14	•••••=															
15																
Mean	0.1525	0.0024	0.1163	19.21	20.94	0.0387	31.43	0.0004	0.0008	1.463	2.872	0.1175	1.0002	20.09	0.0011	0.0077
STDV.	0.0135	0.0005	0.0048	0.189	0.316	0.0029	0.331		0.0001	0.028	0.045	0.0162	0.0249	0.333	0.0007	0.0017
Certified	0.153	0.0024	0.116	19.2	20.9	0.039	31.4	(0.0004)	(0.0008)	1.46	2.87	0.12	1.00	20.1	(0.001)	0.008
U <sub>CRM</sub>	0.008	0.0004	0.003	0.1	0.2	0.002	0.3		(5.0000)	0.02	0.03	0.01	0.02	0.2	(0.001)	0.001
Methods	I,X,IM,O	I,IM	C,O	I,X,O	I,X,O	I,X,IM,O	I,X,O	F	I,X,IM	I,X,IM,O	I,X,IM,O	F,C	I,X,O	I,X,O	F	IM,I,X,O
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	Re	S	Si	Sn	Та	Ti	V	W	Zr				
1	0.0003	0.0004	0.5300	0.0018	0.0004	0.0010	0.0220	2.337	0.0031				
2	0.0180	0.0004	0.5366	<0.005	0.0006	0.0020	0.0230	2.369	0.0047				
3	<0.00005	0.0006	0.5385	≤0.005	0.0014	0.0024	0.0230	2.378	0.0050				
4	<0.0001	0.0008	0.5405	≤0.005	0.0017	0.0026	0.0235	2.389	0.0054				
5	<0.01	0.0010	0.5440		0.0027	0.0026	0.0237	2.391	0.0060				
6	<0.01	0.0022	0.5440		<0.00005	0.0026	0.0243	2.397	0.0060				
7		<0.0005	0.5490		<0.0005	0.0028	0.0245	2.410	0.0060				
8		≤0.005	0.5490		<0.005	0.0034	0.0249	2.422	0.0063				
9		≤0.005	0.5560		≤0.005	0.0036	≤0.005	2.430	0.0068				
10			0.5697			≤0.005	≤0.005	2.439	0.0079				
11			0.5730			≤0.005		2.440	≤0.005				
12			0.5821			≤0.005		2.510					
13								2.530					
14													
15													
Mean	0.0092	0.0009	0.5510	0.0018	0.0014	0.0026	0.0236	2.419	0.0057				
STDV.	0.0125	0.0007	0.0161		0.0009	0.0008	0.0010	0.054	0.0013				
Certified	(<0.01)	(0.0009)	0.55	(<0.005)	(0.001)	0.0026	0.0236	2.42	0.0057				
U <sub>CRM</sub>			0.01			0.0006	0.0008	0.03	0.0009				
Methods	I,IM	C,X,O	I,X,W,O	I,X	I,X,IM	I,X,IM,O	I,X,IM,O	I,X,O	IM,X,I				

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

#### **Certification Laboratories**

- Sheffield Assay Office Massachusetts Materials Research Connecticut Metallurgical, Inc. IMR Test Labs LGC Standards
- Sheffield, UK West Boylston, MA East Hartford, CT Lansing, NY Manchester, NH

Scrooby's Laboratory Service Laboratory Testing, Inc. **Dirats Laboratories** NSL Analytical Services EAG Laboratories

Rynfield, South Africa Hatfield, PA Westfield, MA Cleveland, OH Liverpool, NY

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

#### Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N<sub>prod</sub> is the number of units produced and N<sub>min</sub> is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U<sub>hom</sub>). Uncertainty of the material is calculated by equation 2, where H=U<sub>hom</sub>, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1. 
$$N_{min} = \max(10, \sqrt[3]{N_{prod}})$$
  
2.  $U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$ 

#### **Expiration**

The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Kimberty Halkiotis, Global Product Manager ARMI | MBH - LGC Standards Industrial Sector



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01

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